

Search Notes

Application/Control No.

10/551,048

Examiner

Hae M. Hyeon

Applicant(s)/Patent under
Reexamination

APFELBACHER ET AL.

Art Unit

2839

SEARCHED

Class	Subclass	Date	Examiner
Search	Updated	10/07	hnh

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR